

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/665,312	STUPLE ET AL.
	<b>Examiner</b> Quoc A. Tran	<b>Art Unit</b> 2176

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
INVENTORS SEARCH CHECK FOR DOUBLE PATENT	24/2006	
EAST (US-PAT, US-PGPUB,) See Search Histoty Printout	24/2006	
ACM Digital Librarysee Search History Printout	24/2006	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner